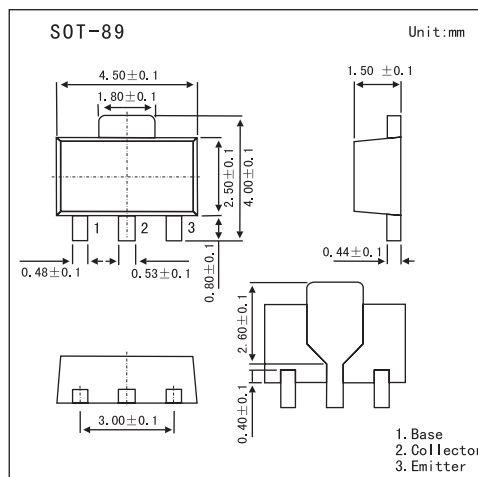


NPN Silicon Epitaxial Transistor 2SD1614

■ Features

- World standard miniature package.
- High dc current gain.
- Low $V_{CE(sat)}$.



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage	V_{CB0}	40	V
Collector-emitter voltage	V_{CE0}	20	V
Emitter-base voltage	V_{EB0}	6	V
Collector current (DC)	I_C	2	A
Collector Current (pulse) *	I_C	3	A
Total power dissipation	P_T	2.0	W
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

* Pulse Test $PW \leq 10\text{ms}$, Duty Cycle $\leq 50\%$.

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Testconditions	Min	Typ	Max	Unit
Collector cutoff current	I_{CBO}	$V_{CB} = 30\text{ V}, I_E = 0\text{ A}$			100	nA
Emitter cutoff current	I_{EBO}	$V_{EB} = 6.0\text{ V}, I_C = 0\text{ A}$			100	nA
DC current gain *	h_{FE}	$V_{CE} = 2.0\text{ V}, I_C = 100\text{ mA}$	135	350	600	
Collector saturation voltage *	$V_{CE(sat)}$	$I_C = 2\text{ A}, I_B = 50\text{ mA}$		0.3	0.5	V
Base saturation voltage *	$V_{BE(sat)}$	$I_C = 2\text{ A}, I_B = 50\text{ mA}$		0.95	1.2	V
Base-emitter voltage *	V_{BE}	$V_{CE} = 6.0\text{ V}, I_C = 100\text{ mA}$	650	680	750	mV
Gain bandwidth product	f_T	$V_{CE} = 10\text{ V}, I_E = -50\text{ mA}$		200		MHz
Output capacitance	C_{ob}	$V_{CB} = 10\text{ V}, I_E = 0, f = 1.0\text{ MHz}$		28		pF

* Pulsed: $PW \leq 350\text{ }\mu\text{s}$, duty cycle $\leq 2\%$

■ h_{FE} Classification

Marking	XM	XL	XK
h_{FE}	135~270	200~400	300~600